

<b>Notice of References Cited</b>	Application/Control No. 10/579,550		Applicant(s)/Patent Under Reexamination LEUCHTE, JURGEN	
	Examiner LOIS ZHENG		Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,669,766	06-1972	Fukawa et al.	148/269
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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